

Application/Control No.	Applicant(s)/Patent under Reexamination
09/913,360	NISHI ET AL.
Examiner	Art Unit
Benny Q. Tieu	2642

SEARCHED						
Class	Subclass	Date	Examiner			
455	352 418 92	6/24/2005	BQT			
709	217					
370	312 390					
725	39 86					

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
	-				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	6/24/2005	BQT	